

Notice of References Cited

Application/Control No.

09/704,638

Applicant(s)/Patent Under
Reexamination
DOERR ET AL.

Examiner

Scott L. Jarrett

Art Unit

3623

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,291,397	03-1994	Powell, Roger A.	700/97
*	B	US-5,303,170	04-1994	Valko, Andrew G.	703/2
*	C	US-5,918,219	06-1999	Isherwood, John Philip	705/37
*	D	US-5,798,950	08-1998	Fitzgerald, Joseph Michael	703/17
*	E	US-6,889,196	05-2005	Clark, Douglas	705/9
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Finely, Eric et al., Project Scheduling Risk Assessment Using Monte Carlo Methods Cost Engineering, October 1994, Vol. 36, No. 10, Pages 24-28
	V	Ranasinghe, Malik, Quantification and management of uncertainty in activity duration networks Construction Management and Economics, January 1994, Vol. 12, No. 1, Abstract
	W	Yahng, Kum-Khiong, Effects for Erroneous Estimation of Activity Duration on Scheduling and Dispatching a Single Project Decision Sciences, Spring 1996, Vol. 27, No. 2, Pages 255-290
	X	Ock, Jong H., Activity duration quantification under uncertainty, Fuzzy set theory application Cost Engineering, January 1996, Vol. 38, No. 1

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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	D	US-			
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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Dawood, Nashwan, Estimating project and activity duration: A risk management approach using network analysis Construction Management and Economics, January 1998, Vol. 16, No. 1, Abstract
	V	Marsh, Thomas, Palisade upgrades @Risk software Corporate Finance, September 1998, No. 166
	W	Cummings, Nigel, @Risk delivers richer picture Operational Research Society - OR Newsletter, February 1999
	X	ScramSoftware.com Web Pages April 2000, Retrieved from Archive.org April 5, 2006

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Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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	C	US-			
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	G	US-			
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	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Palisade.com Web Pages May-June 2000, Retrieved from Archive.org April 7, 2006
	V	Pyron, Tim, Teach Yourself Microsoft Project 98 in 24 hours Sams Publishing, May 1998, ISBN: 0-672-31258-1
	W	Essentials of expressing measurement uncertainty The NIST reference on Constants, Units and Uncertainty, Retrieved from Physics.nist.gov, April 7, 2005
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.